



Specification for Approval

Date: 2012/03/13

Customer: 協裕

TAI-TECH P/N: HPC4018 Series

CUSTOMER P/N:

DESCRIPTION:

QUANTITY: pcs

REMARK:			
Cu	stomer Approval Feedba	ack	
4 (1CC	5	

西北臺慶科技股份有限公司 TAI-TECH Advanced Electronics Co., Ltd

■ 西北臺慶科技股份有限公司

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Peter Tzou	Ryan Lin	Yu-tian Siao

Power Inductor

HPC4018 Series

		ECN HISTORY	LIST		
REV	DATE	DESCRIPTION	APPROVED	CHECKED	DRAWN
1.0	12/03/13	新 發 行	鄒俊德	林祺寧	蕭羽恬
			5		
備					
註					

Power Inductor

HPC4018 Series

1. Features

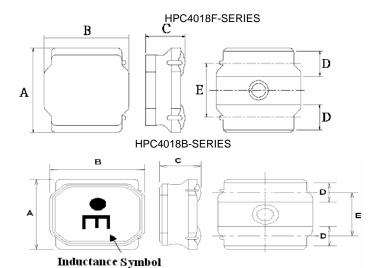
- 1. This specification applies Low Profile Power Inductors.
- 2. 100% Lead(Pb) & Halogen-Free and RoHS compliant.

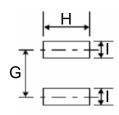
2. Dimension





Units: mm





Series	A(mm)	B(mm)	C(mm)	D(mm)	E(mm)	G(mm)	H(mm)	I(mm)
HPC4018F/B	4.0±0.2	4.0±0.2	1.8 max.	1.1±0.2	2.5±0.2	2.8 ref.	3.7 ref.	1.2 ref.

3. Part Numbering

HPC A **4018** B





D



- A: Series
- B: Dimension
- C: Control S/N
- D: Inductance
- E: Inductance Tolerance
- 2R2=2.2uH
- M=±20%; Y=±30%

4. Specification

TAI-TECH Part Number	Inductance (uH)	Tolerance (%)	Test Frequency (Hz)	SRF (MHz) min.	DCR (Ω) ±20%	I sat (A)	I rms (A)
HPC4018F-1R0Y	1.0	±30%	1V100K	80	0.030	4.00	1.83
HPC4018F-2R2M	2.2	±20%	1V100K	52	0.060	2.70	1.44
HPC4018F-3R3M	3.3	±20%	1V100K	44	0.070	2.00	1.23
HPC4018F-4R7M	4.7	±20%	1V100K	34	0.090	1.70	1.20
HPC4018F-6R8M	6.8	±20%	1V100K	29	0.110	1.45	1.060
HPC4018F-100M	10	±20%	1V100K	24	0.180	1.20	0.84
HPC4018F-150M	15	±20%	1V100K	19	0.250	0.94	0.65
HPC4018F-220M	22	±20%	1V100K	16	0.360	0.80	0.59
HPC4018F-330M	33	±20%	1V100K	12	0.530	0.65	0.49
HPC4018F-470M	47	±20%	1V100K	10	0.650	0.57	0.42
HPC4018F-680M	68	±20%	1V100K	8.3	1.00	0.47	0.32
HPC4018F-101M	100	±20%	1V100K	6.5	1.50	0.40	0.27
HPC4018F-151M	150	±20%	1V100K	5.5	2.50	0.31	0.22
HPC4018F-221M	220	±20%	1V100K	4.0	4.00	0.27	0.17

TAI-TECH Part Number	Inductance Symbol	Inductance (uH)	Tolerance (%)	Test Frequency (Hz)	SRF (MHz) min.	DCR (Ω) ±20%	l sat (A)	I rms (A)
HPC4018B-1R0Y	Α	1.0	±30%	1V100K	90	0.027	4.00	3.20
HPC4018B-2R2M	С	2.2	±20%	1V100K	60	0.042	3.00	2.20
HPC4018B-3R3M	Е	3.3	±20%	1V100K	45	0.055	2.30	2.00
HPC4018B-4R7M	Н	4.7	±20%	1V100K	35	0.070	2.00	1.70
HPC4018B-6R8M	ı	6.8	±20%	1V100K	30	0.098	1.60	1.45
HPC4018B-100M	K	10	±20%	1V100K	25	0.150	1.30	1.20
HPC4018B-150M	М	15	±20%	1V100K	18	0.210	1.10	0.85
HPC4018B-220M	N	22	±20%	1V100K	15	0.290	0.90	0.72
HPC4018B-330M	Р	33	±20%	1V100K	12	0.460	0.70	0.55

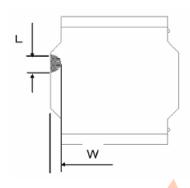
Note:

 $\mbox{Isat}: \mbox{Based on inductance change} \quad (\ \triangle \mbox{L/L0}: \ {\leq} \mbox{-30\%} \) \ \ @ \mbox{ ambient temp. } \mbox{25}{\%}$

Irms : Based on temperature rise $(\triangle T : 40^{\circ}C \text{ typ.})$

Core chipping

The appearance standard of the chipping size in top side, of bottom side ferrite core is following dimension.

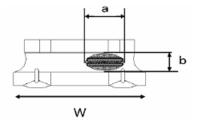


	Туре	L	W
HPC4018F/B 1.5 1.5	HPC4018F/B	1.5	1.5

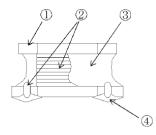
Exposed wire tolerance limit of coating resin part on product side.

Size of exposed wire occurring to coating resin is specified below.

- Width direction (dimension a): Acceptable when a≤w/2
 Nonconforming when a>w/2
- 2. Length direction (dimension b): Dimension b is not specified.
- 3. When total area of exposed wire occurring to each sides is not greater than 50% of coating resin area, that is acceptable.



5. Material List



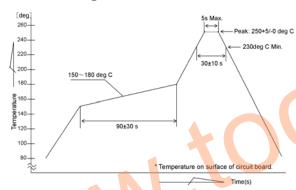
No.	Item	Material
1	Core	Ni-Zn ferrite
2	Wire	Copper Wire
3	Coating	Ероху
4	Solder	Lead free

6. Reliability and Test Condition

Item	Performance	emarks			
Operating Temperature	F Type: - 25 ~ +120°C. B Type: - 25 ~ +125°C.	Including self-g	generated heat		
Storage Temperature	-40 ~ +85°C. - 5 to 40°C for the product with taping.				
Rated current					
Inductance (L)	Within the specified tolerance	LCR Meter: HP	4285A or equivalent	, 100kHz, 1V	
DC Resistance		DC Ohmmeter:	: HIOKI3227 or equiva	alent	
Temperature characteristics	Inductance change: Within±20%	rang within–25 With reference shall be calcula Measurement of rang within–40 With reference shall be calcula	to inductance value a ated. of inductance shall be $\mathbb C$ to +125 $\mathbb C$. to inductance value a ated.	at+20 °C,change ra taken at tempera at+20 °C,change ra	ate iture ate
Resistance to flexure substrate	No damage.	the reflow. As illustrated b indicating until RS Substrate size Substrate mate Solder cream the size of the size	erial : glass epoxy-reshickness : 0.15	ne direction of the board reaches to 2	arrow 2mm.
Adhesion of Terminal electrode	Shall not come off PC board.	Applied force: Duration: 5s	10 N, 5 s 10 N to X and Y direct hickness: 0.15		d and
Resistance to Vibration	Inductance change: Within±10% No abnormality observed in appearance.	reflow. Then it shall be Frequency: 10- Total Amplitude 196m/S2) Sweeping Meth Time: 2 hours Recovery: At let	es shall be soldered to esubmitted to below to 55Hz e: 1.5mm (May not exhaud: 10Hz to 55Hz to each in X,Y, and Z Deast 2hrs of recovery the test, followed by to	est conditions. ceed acceleration 10Hz for 1min. virection. under the standard	n d
Solderability	At least 90% of surface of terminal electrode is covered by new solder.	in molten solde Flux: methand Solder tempera Time: 5±1.0 se		rosin 25%	
Resistance to soldering		for 40 seconds seconds,2 time Test board thic		ire at 260±5°C for	
Thermal shock	Inductance change: Within±10% No abnormality observed in appearance.	The test samples shall be soldered to the test board by the reflow. The test samples shall be placed at specified temperature for specified time by step 1 to step 4 as shown below in sequence. The temperature cycles shall be repeated 100 cycles. Phase Temperature(C) Time(min.) 1			
		3 4	85±2℃ RoomTemp	30±3 Within 3	

Item	Performance	Test Method and Remarks
Damp heat life test		Test Method and Remarks The test samples shall be soldered to the test board by the reflow. The test samples shall be placed in thermostatic oven set at specified temperature and humidity as shown in below. Temperature: 60±2°C Humidity: 90–95%RH Time: 500+24/-0 hrs
Loading under damp heat life test	Inductance change: Within±10% No abnormality observed in appearance.	The test samples shall be soldered to the test board by the reflow. The test samples shall be placed in thermostatic oven set at specified temperature and humidity and applied the rated current continuously as shown in below. Temperature: 60±2°C Humidity: 90–95%RH Applied current: Rated current Time: 500+24/-0 hrs
Low temperature life test		The test samples shall be soldered to the test board by the reflow. After that, the test samples shall be placed at test conditions as shown in below. Temperature:-40±2°C Time:500+24/-0 hrs
Loading at high temperature life test		The test samples shall be soldered to the test board by the reflow. Temperature: 85±2°C . Applied current: Rated current Time: 500+24/-0 hrs.

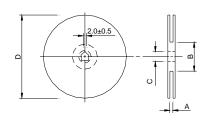
7. Soldering

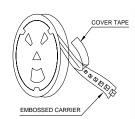


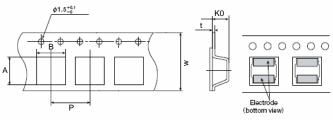
8. Packaging Information

(1) Reel Dimension

(2) Tape Dimension







Туре	A(mm)	B(mm)	C(mm)	D(mm)
HPC4018F/B	13.5±1.0	80±2.0	13±0.5	330±3.0

Туре	A(mm)	B(mm)	Ko(mm)	P(mm)	W(mm)	t(mm)
HPC4018F/B	4.3±0.1	4.3±0.1	2.1±0.1	8.0±0.1	12±0.3	0.3±0.1

(3) Packaging Quantity

Туре	Chip / Reel		
HPC4018F/B	3500		

Application Notice

- Storage Conditions
- To maintain the solderability of terminal electrodes:
- 1. TAI-TECH products meet IPC/JEDEC J-STD-020D standard-MSL, level 1.
- 3. Recommended products should be used within 6 months form the time of delivery.
- 4. The packaging material should be kept where no chlorine or sulfur exists in the air.
- Transportation

- 1. Products should be handled with care to avoid damage or contamination from perspiration and skin oils.
- 2. The use of tweezers or vacuum pick up is strongly recommended for individual components.
- 3. Bulk handling should ensure that abrasion and mechanical shock are minimized.



測試報告

Test Report

號碼(No.): CE/2011/44058 日期(Date): 2011/04/26 頁數(Page): 1 of 8

西北臺慶科技股份有限公司 / TAI-TECH ADVANCED ELECTRONICS CO., LTD.

(東莞臺慶精密電子有限公司 / TAI-TECH ADVANCED ELECTRONICS (DONGGUAN) CO., LTD.)

(臺慶精密電子 (昆山) 有限公司 / TAI-TECH ADVANCED ELECTRONICS (KUN-SHAN) CO., LTD.)

桃園縣楊梅鎮幼獅工業區幼四路1之1號 / NO. 1, YOU 4TH ROAD, YOUTH INDUSTRIAL DISTRICT,

YANG-MEI, TAO-YUAN HSIEN, TAIWAN, R. O. C.

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HUANGJIANG TOWN, DONGGUAN, GUANGDONG)

(江蘇省昆山市篷朗昆嘉高科技工業區郭澤路 / GUO-ZE ROAD, KUNJIA HI-TECH INDUSTRIAL PARK,

KUN-SHAN, JIANG-SU, CHINA)

以下測試樣品係由客户送樣, 且由客户聲稱並經客户確認如下 (The following samples was/were submitted and identified by/on behalf of the client as):

樣品名稱(Sample Description)

: INDUCTOR

樣品型號(Style/Item No.)

HPC/SPI SERIES

收件日期(Sample Receiving Date)

2011/04/19

測試期間(Testing Period)

: 2011/04/19 TO 2011/04/26

測試結果(Test Results)

: A請見下一頁 (Please refer to next pages).

Shinjyh Chen Asst. Manager Signed for and on begalvor. SGS TAIWAN LTD.

Chemical Laboratory - Taipei

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Test Report

西北臺慶科技股份有限公司 / TAI-TECH ADVANCED ELECTRONICS CO., LTD. (東莞臺慶精密電子有限公司 / TAI-TECH ADVANCED ELECTRONICS (DONGGUAN) CO., LTD.) (臺慶精密電子 (昆山) 有限公司 / TAI-TECH ADVANCED ELECTRONICS (KUN-SHAN) CO., LTD.) 桃園縣楊梅鎮幼獅工業區幼四路1之1號 / NO. 1, YOU 4TH ROAD, YOUTH INDUSTRIAL DISTRICT, YANG-MEI, TAO-YUAN HSIEN, TAIWAN, R. O. C. (廣東省東莞市黄江鎮黄牛埔福祥街2號 / NO. 2, FUXIANG STREET, HUANGNIUPU, HUANGJIANG TOWN, DONGGUAN, GUANGDONG)

(江蘇省昆山市篷朗昆嘉高科技工業區郭澤路 / GUO-ZE ROAD, KUNJIA HI-TECH INDUSTRIAL PARK, KUN-SHAN, JIANG-SU, CHINA)

測試結果(Test Results)

測試部位(PART NAME) No.1 :

INDUCTOR

測試項目 (Test Items) 鎬 / Cadmium (Cd)	單位 (Unit)	測試方法 (Method) 參考IEC 62321: 2008方法,以感	方法偵測 極限値 (MDL) 2	結果 (Result) No.1
yay / Cadiii diii (Cd)		應耦合電漿原子發射光譜儀檢測. / With reference to IEC 62321: 2008 and performed by ICP-AES.	-	
鉛 / Lead (Pb)	mg/kg	參考IEC 62321: 2008方法, 以感 應耦合電漿原子發射光譜儀檢測. / With reference to IEC 62321: 2008 and performed by ICP-AES.	2	n.d.
汞 / Mercury (Hg)	mg/kg	參考IEC 62321: 2008方法, 以感 應耦合電漿原子發射光譜儀檢測. / With reference to IEC 62321: 2008 and performed by ICP-AES.	2	n.d.
六價格 / Hexavalent Chromium Cr(VI) by alkaline extraction	mg/kg	參考IEC 62321: 2008方法,以UV-VIS檢測. / With reference to IEC 62321: 2008 and performed by UV-VIS.	2	n.d.

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(廣東省東莞市黄江鎮黄牛埔福祥街2號 / NO. 2, FUXIANG STREET, HUANGNIUPU, HUANGJIANG TOWN, DONGGUAN, GUANGDONG)

(江蘇省昆山市篷朗昆嘉高科技工業區郭澤路 / GUO-ZE ROAD, KUNJIA HI-TECH INDUSTRIAL PARK, KUN-SHAN, JIANG-SU, CHINA)

測試項目 (Test Items)	單位 (Unit)	測試方法 (Method)	方法偵測 極限値 (MDL)	結果 (Result) No.1
多溴聯苯總和 / Sum of PBBs 一溴聯苯 / Monobromobiphenyl 二溴聯苯 / Dibromobiphenyl 三溴聯苯 / Tribromobiphenyl 四溴聯苯 / Pentabromobiphenyl 六溴聯苯 / Hexabromobiphenyl 六溴聯苯 / Octabromobiphenyl 九溴聯苯 / Nonabromobiphenyl 九溴聯苯 / Decabromobiphenyl 十溴聯苯 / Decabromobiphenyl 李溴聯苯醚 / Monobromodiphenyl ether 二溴聯苯醚 / Tribromodiphenyl ether 三溴聯苯醚 / Tetrabromodiphenyl ether 二溴聯苯醚 / Hexabromodiphenyl ether 二溴聯苯醚 / Hexabromodiphenyl ether 九溴聯苯醚 / Hexabromodiphenyl ether 九溴聯苯醚 / Hexabromodiphenyl ether 九溴聯苯醚 / Hexabromodiphenyl ether 九溴聯苯醚 / Octabromodiphenyl ether 九溴聯苯醚 / Nonabromodiphenyl ether 九溴聯苯醚 / Nonabromodiphenyl ether	mg/kg	参考IEC 62321: 2008方法, 以氣相層析儀/質譜儀檢測. / With reference to IEC 62321: 2008 and performed by GC/MS.	(MDL) - 5 5 5 5 5 5 5 5 5 5 5 5 5 5 5 5 5 5	No.1 n.d. n.d. n.d. n.d. n.d. n.d. n.d. n.

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(臺慶精密電子 (昆山) 有限公司 / TAI-TECH ADVANCED ELECTRONICS (KUN-SHAN) CO., LTD.)

桃園縣楊梅鎮幼獅工業區幼四路1之1號 / NO. 1, YOU 4TH ROAD, YOUTH INDUSTRIAL DISTRICT,

YANG-MEI, TAO-YUAN HSIEN, TAIWAN, R. O. C.

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HUANGJIANG TOWN, DONGGUAN, GUANGDONG)

(江蘇省昆山市篷朗昆嘉高科技工業區郭澤路 / GUO-ZE ROAD, KUNJIA HI-TECH INDUSTRIAL PARK,

KUN-SHAN, JIANG-SU, CHINA)

測試項目 (Test Items)	單位 (Unit)	測試方法 (Method)	方法偵測 極限値 (MDL)	結果 (Result) No.1
鹵素 / Halogen 鹵素 (氣) / Halogen-Fluorine (F) (CAS No.: 14762-94-8)			50	n.d.
鹵素(氣)/ Halogen-Chlorine(Cl) (CAS No.: 22537-15-1)	mg/kg	参考BS EN 14582:2007, 以離子層 析儀分析. / With reference to	50	n.d.
鹵素(溴)/ Halogen-Bromine (Br) (CAS No.: 10097-32-2)	mg/kg	BS EN 14582:2007. Analysis was performed by IC.	50	n.d.
鹵素(碘)/ Halogen-Iodine(I) (CAS No.: 14362-44-8)	-	100	50	n.d.

備註(Note):

- 1. mg/kg = ppm; 0.1wt% = 1000ppm
- 2. n.d. = Not Detected (未檢出)
- 3. MDL = Method Detection Limit (方法偵測極限値)
- 4. "-" = Not Regulated (無規格値)
- 5. 此份報告取代簽署人為Chenyu Kung之CE/2011/44058報告. (This report supersedes the previous document bearing the test report number CE/2011/44058 which signed by Chenyu Kung.)

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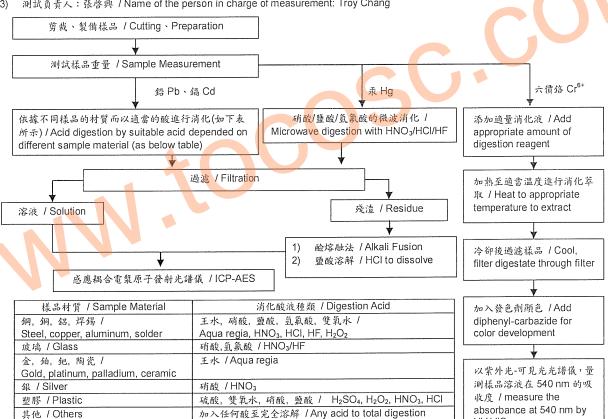
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- 根據以下的流程圖之條件,樣品已完全溶解。(六價鉻測試方法除外) / These samples were dissolved totally by pre-conditioning method according to below flow chart. (Cr6+ test method excluded) 測試人員:楊登偉 / Name of the person who made measurement: Climbgreat Yang
- 測試負責人:張啓興 / Name of the person in charge of measurement: Troy Chang



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UV-VIS



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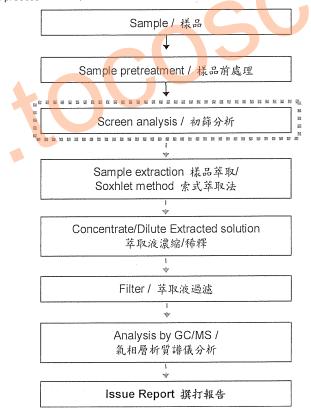
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(江蘇公見小市家館見真真科技工業區郭澤敦 / GUO-7F ROAD KUNIIA HI-TECH INDUS

(江蘇省昆山市篷朗昆嘉高科技工業區郭澤路 / GUO-ZE ROAD, KUNJIA HI-TECH INDUSTRIAL PARK, KUN-SHAN, JIANG-SU, CHINA)

多溴聯苯/多溴聯苯醚分析流程圖 / PBB/PBDE analytical FLOW CHART

1) 測試人員: 翁賜彬 / Name of the person who made measurement: Roman Wong



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鹵素分析流程圖 / Analytical flow chart of halogen content

- 1) 測試人員: 陳恩臻 / Name of the person who made measurement: Rita Chen
- 2) 測試負責人:張啓興 / Name of the person in charge of measurement: Troy Chang



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